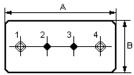
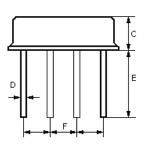


Tel : +44 118 979 1238 Fax : +44 118 979 1283 Email: <u>info@actcrystals.com</u>

The ACTR433.92/433.92/F11-1.5 is a true one-port, surface-acoustic-wave (SAW) resonator in a low-profile metal F-11 case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at 433.920 MHz.

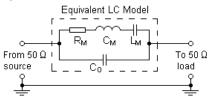
### 1.Package Dimension (F-11)





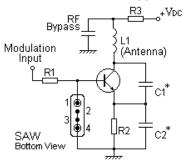
Pin	Configuration			
1,4	Input / Output			
2/3	Case Ground			
Dimension	n Data (unit: mm)			
А	11.0±0.3			
В	4.5±0.3			
С	3.2±0.3			
D	0.45±0.1			
E	5.0±0.5			
F	2.54±0.2			

3.Equivalent LC Model and Test Circuit

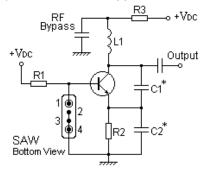


## **4.Typical Application Circuits**

1) Low-Power Transmitter Application



2) Local Oscillator Application



In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

#### ISO9001: 2000 Registered

For quotations or further information please contact us at:

Issue : 1.1 C1 Date : March 2010

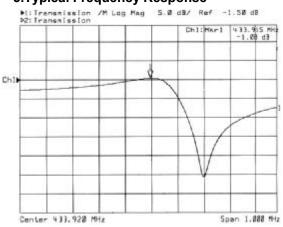
3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK

# http://www.actcrystals.com



Tel : +44 118 979 1238 Fax : +44 118 979 1283 Email: <u>info@actcrystals.com</u>

### 6.Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.

7.Performance

7-1	Maximum	Ratings
	ivianiiiuiii	raungs

	V	
Rating	Value	Unit
CW RF Power Dissipation	0	dBm
DC Voltage Between Terminals	±30V	VDC
Case Temperature	-40 to +85	°C

	Characteristic	Sym	Minimum	Typical	Maximum	Unit
Centre Frequency (+25°C)	Absolute Frequency	fc	433.845		433.995	MHz
	Tolerance from 433.920MHz	$\Delta f_{C}$		±75		kHz
Insertion Loss		IL		1.5	2.2	dB
Quality Factor	Unloaded Q	QU		10,350		
	50 Ω Loaded Q	QL		1,650		
Temperature Stability	Turnover Temperature	T <sub>0</sub>	25		55	°C
	Turnover Frequency	f <sub>0</sub>		f <sub>C</sub>		kHz
	Frequency Temperature Coefficient	FTC		0.032		ppm/°C
Frequency Aging Absolute Value during the First Year		f <sub>A</sub>		≤10		ppm/yr
DC Insulation Resistance Between Any Two Pins			1.0			MΩ
RF Equivalent RLC Model	Motional Resistance	R <sub>M</sub>		19	29	Ω
	Motional Inductance	L <sub>M</sub>		72.0546		μH
	Motional Capacitance	См		1.8690		fF
	Pin 1 to Pin 4 Static Capacitance	C <sub>0</sub>	1.8	2.1	2.4	pF

## 7-2. Electronic Characteristics

## **i** CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

### ISO9001: 2000 Registered

For quotations or further information please contact us at:

Issue : 1.1 C1 Date : March 2010

3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK

http://www.actcrystals.com



- 1. The centre frequency,  $f_c$ , is measured at the minimum IL point with the resonator in the 50  $\Omega$  test system. 2. Unless noted otherwise, case temperature  $T_c = +25^{\circ}C \pm 2^{\circ}C$ .
- 3. Frequency aging is the change in f<sub>C</sub> with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- 4. Turnover temperature,  $\overline{f}_0$ , is the temperature of maximum (or turnover) frequency,  $f_0$ . The nominal frequency at any case temperature, T<sub>c</sub>, may be calculated from:  $f = f_0 [1 - FTC (T_0 - T_c)^2]$ .
- This equivalent RLC model approximates resonator performance near the resonant frequency and is provided 5. for reference only. The capacitance  $C_0$  is the measured static (non-motional) capacitance between Pin1 and Pin4. The measurement includes case parasitic capacitance.
- 6. Derived mathematically from one or more of the following directly measured parameters: f <sub>C</sub>, IL, 3 dB bandwidth, f<sub>C</sub> versus T<sub>C</sub>, and C<sub>0</sub>.
- 7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- 8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- 9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

ISO9001: 2000 Registered

Issue : 1.1 C1 Date : March 2010

For quotations or further information please contact us at:

3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK